

**Search Notes****Application/Control No.**

10/619,682

**Examiner**

Jeffery A. Brier

**Applicant(s)/Patent under Reexamination**

WITT ET AL.

**Art Unit**

2628

**SEARCHED**

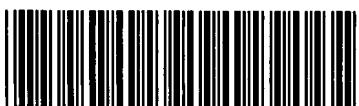
Class	Subclass	Date	Examiner
345	592, 611, 613, 614, 629, 634,	7/7/2005	JB
345	639	7/7/2005	JB
348	584,	7/7/2005	JB
348	598-601	7/7/2005	JB
updated	above	7/21/2006	JB
updated	above	12/20/2006	JB

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EDAN inventor search	7/7/2005	JB
EAST text search (US-PGUB, USPAT, USOCR, EPO, JPO, DERWENT, IBM_TDB). See search history printout.	7/7/2005	JB
CiteSeer text search. See search history printout.	7/6/2005	JB
EAST text search (US-PGUB, USPAT, USOCR, EPO, JPO, DERWENT, IBM_TDB). See search history printout.	7/21/2006	JB

<b>Search Notes</b>	<b>Application/Control No.</b>	<b>Applicant(s)/Patent Under Reexamination</b>
	10619682	WITT ET AL.
	<b>Examiner</b> Brier, Jeffery A	<b>Art Unit</b> 2628

### SEARCHED

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
updated previous search.		5/22/2007	JB

### SEARCH NOTES

<b>Search Notes</b>	<b>Date</b>	<b>Examiner</b>
EAST text search (US-PGPUB, USPAT, USOCR, FPRS, EPO, JPO, DERWENT, IBM TDB). See search history printout.	5/22/2007	JB

### INTERFERENCE SEARCH

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>